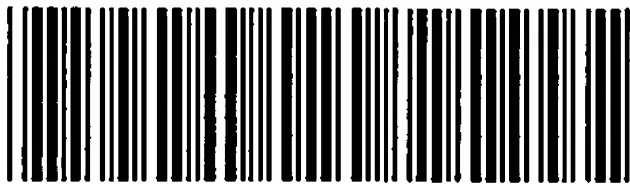


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/645,708	KILMER ET AL.	
	Examiner	Art Unit	
	Yicun Wu	2165	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10, 100-104.1 200-206	4/26/2006	YW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor search (double patenting) uspto uspgpub epo jpo ibmtech derwent	4/26/2006	YW
acm ieee citeseer internet Search stratagy attached	4/26/2006	YW
consulted Apu Mofiz	4/26/2006	YW
consulted Pat Salce	4/25/2006	YW